

P-Channel Enhancement Mode Power MOSFET

Description

The HM6409 uses advanced trench technology to provide excellent $R_{DS(ON)}$, low gate charge and operation with gate voltages as low as 2.5V. This device is suitable for use as a load switch or in PWM applications.

General Features

• $V_{DS} = -20V, I_{D} = -5.0A$

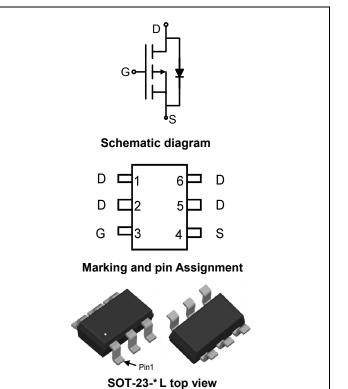
 $R_{DS(ON)}$ <75m Ω @ V_{GS} =-2.5V

 $R_{DS(ON)}$ < 52m Ω @ V_{GS} =-4.5V

- High power and current handing capability
- Lead free product is acquired
- Surface mount package

Application

- PWM applications
- Load switch
- Power management



Package Marking and Ordering Information

Device Marking	Device	Device Package	Reel Size	Tape width	Quantity
6409	HM6409	SOT-23-6L	Ø180mm	8 mm	3000 units

Absolute Maximum Ratings (T_A=25 ℃unless otherwise noted)

Paramete	r	Symbol	Limit	Unit	
Drain-Source Voltage		V _{DS}	-20	V	
Gate-Source Voltage		V _G s	±12	V	
	T _C =25℃		-5.0		
Continuous Drain Current	T _C =70℃	1	-3.5	A	
Continuous Drain Current	T _A =25℃	l _D	-3		
	T _A =70°C		-2.3		
Drain Current -Pulsed (Note 1)		I _{DM}	-15	Α	
Maximum Power Dissipation		P _D	1.7	W	
Operating Junction and Storage Tempe	rature Range	T_{J}, T_{STG}	-55 To 150	$^{\circ}$	

Thermal Characteristic

Thermal Resistance, Junction-to-Ambient (Note 2)	R _{0JA}	74	°C/W
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Electrical Characteristics (T_A=25 °C unless otherwise noted)

Parameter	Parameter Symbol Condition		Min	Тур	Max	Unit	
Off Characteristics							
Drain-Source Breakdown Voltage	BV _{DSS}	V _{GS} =0V I _D =-250μA	-20	-	-	V	
Zero Gate Voltage Drain Current	I _{DSS}	V _{DS} =-20V,V _{GS} =0V	-	-	-1	μA	
Gate-Body Leakage Current	I _{GSS}	V _{GS} =±12V,V _{DS} =0V	-	-	±100	nA	
On Characteristics (Note 3)	•					•	
Gate Threshold Voltage	V _{GS(th)}	V _{DS} =V _{GS} ,I _D =-250μA	-0.45	-0.7	-1.0	V	
D. 1. 0 0. 0. 1. 1. D. 1. 1		V _{GS} =-4.5V, I _D =-5.0A	- 39 52		52		
Drain-Source On-State Resistance	R _{DS(ON)}	V _{GS} =-2.5V, I _D =-3A	-	58	75	mΩ	
Forward Transconductance	g FS	V _{DS} =-5V,I _D =-2A	6	-	-	S	
Dynamic Characteristics (Note4)		1		I.			
Input Capacitance	C _{lss}	\/ 4\/\/ 0\/	-	740	-	PF	
Output Capacitance	C _{oss}	V_{DS} =-4V, V_{GS} =0V, F=1.0MHz	-	290	-	PF	
Reverse Transfer Capacitance	C _{rss}	F=1.UIVIFIZ	-	190	-	PF	
Switching Characteristics (Note 4)	·						
Turn-on Delay Time	t _{d(on)}		-	12	-	nS	
Turn-on Rise Time	t _r	V_{DD} =-4 V , I_{D} =-3.3 A ,	-	35	-	nS	
Turn-Off Delay Time	$t_{\sf d(off)}$	R_L =-1.2 Ω , V_{GEN} =-4.5 V , R_g =1 Ω	-	30	-	nS	
Turn-Off Fall Time	t _f	-	-	10	-	nS	
Total Gate Charge	Qg		-	7.8	-	nC	
Gate-Source Charge	Q _{gs}	V _{DS} =-4V,I _D =-5.0A,V _{GS} =-4.5V	-	1.2	-	nC	
Gate-Drain Charge	Q_{gd}	1	-	1.6	-	nC	
Drain-Source Diode Characteristics	•		•	•			
Diode Forward Voltage (Note 3)	V_{SD}	V _{GS} =0V,I _S =-1.6A	-	-	-1.2	V	
Diode Forward Current (Note 2)	Is		-	-	1.6	Α	

Notes:

- 1. Repetitive Rating: Pulse width limited by maximum junction temperature.
- 2. Surface Mounted on FR4 Board, t ≤ 10 sec.
- 3. Pulse Test: Pulse Width ≤ 300µs, Duty Cycle ≤ 2%.
- 4. Guaranteed by design, not subject to production

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Typical Electrical and Thermal Characteristics

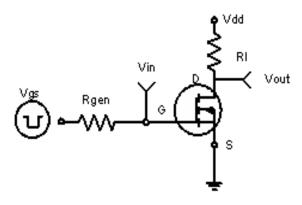
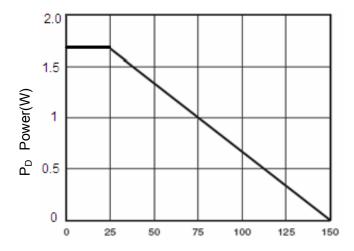


Figure 1:Switching Test Circuit



T_J-Junction Temperature(°C)

Figure 3 Power Dissipation

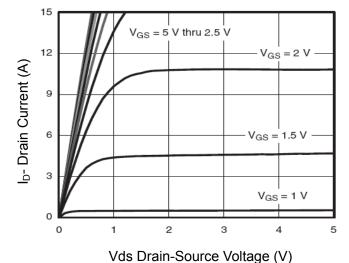


Figure 5 Output Characteristics

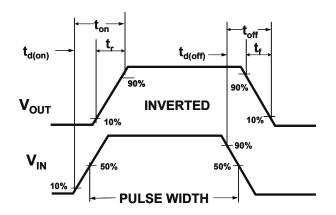
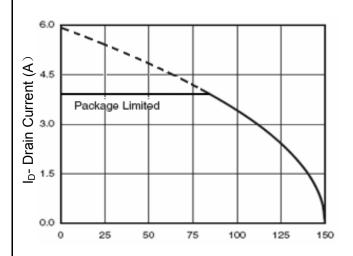
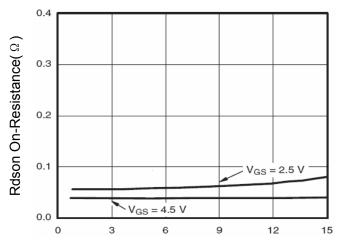


Figure 2:Switching Waveforms



 T_J -Junction Temperature($^{\circ}$ C)

Figure 4 Drain Current

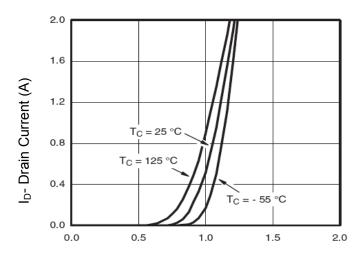


I_D- Drain Current (A)

Figure 6 Drain-Source On-Resistance

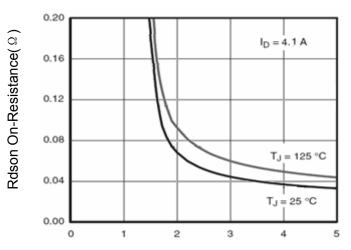
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Vgs Gate-Source Voltage (V)

Figure 7 Transfer Characteristics



Vgs Gate-Source Voltage (V)

Figure 9 Rdson vs Vgs

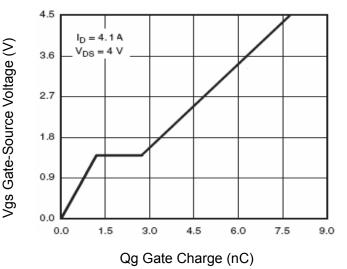
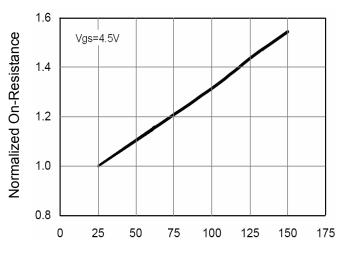
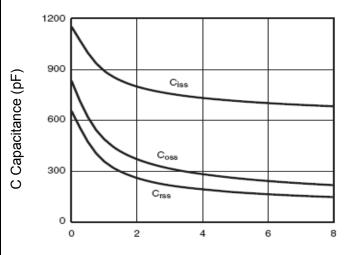


Figure 11 Gate Charge



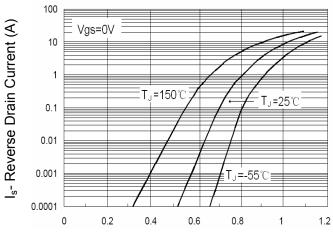
T_J-Junction Temperature(°C)

Figure 8 Drain-Source On-Resistance



Vds Drain-Source Voltage (V)

Figure 10 Capacitance vs Vds



Vsd Source-Drain Voltage (V)

Figure 12 Source- Drain Diode Forward

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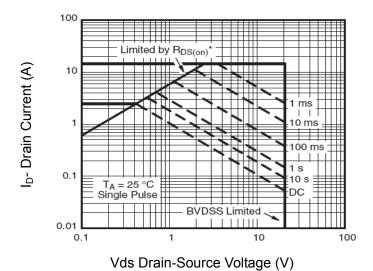


Figure 13 Safe Operation Area

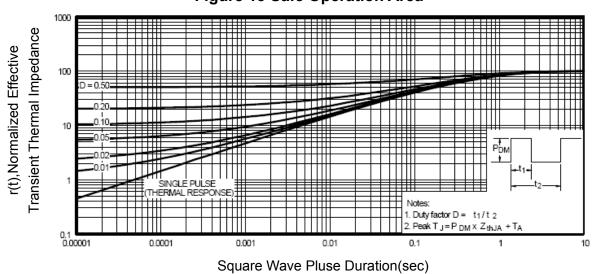
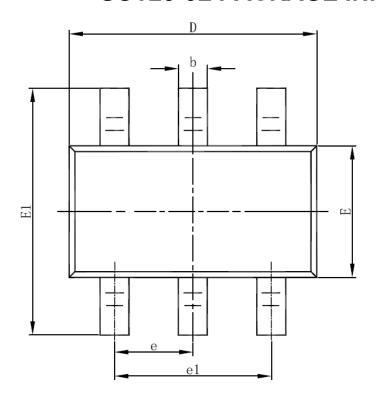


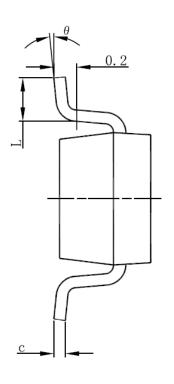
Figure 14 Normalized Maximum Transient Thermal Impedance

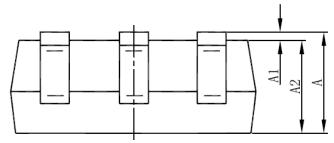
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SOT23-6L PACKAGE INFORMATION







Symbol	Dimensions In Millimeters		Dimensions In Inches		
	Min	Max	Min	Max	
Α	1.050	1.250	0.041	0.049	
A1	0.000	0.100	0.000	0.004	
A2	1.050	1.150	0.041	0.045	
b	0.300	0.500	0.012	0.020	
С	0.100	0.200	0.004	0.008	
D	2.820	3.020	0.111	0.119	
E	1.500	1.700	0.059	0.067	
E1	2.650	2.950	0.104	0.116	
е	0.950(BSC)		0.037(BSC)		
e1	1.800	2.000	0.071	0.079	
L	0.300	0.600	0.012	0.024	
θ	0°	8°	0°	8°	

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